



Research Article

Development of an Analytical Method for the Determination of Trace Metallic Constituents in ZrO₂ Matrix by D.C. Arc AES Technique

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Abstract

Determination of trace metallic constituents in nuclear materials being one of the important steps of chemical quality control is regularly followed to achieve the desired performance of the nuclear materials in the nuclear reactors. Zirconium (Zr) having low nuclear absorption cross section is used not only as cladding materials for encapsulating nuclear fuels but also in advance fuel materials like U-Zr, U-Pu-Zr alloy etc. In the present study, a method for direct determination of trace elements (19 volatile impurity elements) at concentrations as low as a fraction of a part per million in ZrO₂ matrix has been developed by Atomic Emission Spectroscopic (AES) technique based on d.c. arc carrier distillation using 5% carrier consisting of a mixture of AgCl and SrF₂ (4:1). A direct reading atomic emission spectrometer with computerized data acquisition and processing facility has been used in these studies. The experimental parameters have been optimized for the direct determination of Co, Cr, Mg, B, Be, Cd, Sn, Mn, Cu, Ni, V, Ca, Pb, Fe, Ti, Al, Mo, W and Si and the detection limits and sensitivity of the analytes were determined. The suitability of the method developed was confirmed by the analysis of synthetic samples of ZrO₂. The method appears to be promising for simultaneous and direct determination of the above trace metals in ZrO₂ with an overall relative standard deviation of ~15%.

Keywords: Zirconia, d.c.arc. carrier distillation, trace elements

Introduction

Zirconium oxide has many applications in the nuclear and chemical industries. It is the starting material for fabrication of ceramic and metallic fuels proposed to be used widely in nuclear industry. Since

zircaloy is resistant to embrittlement and has very low neutron absorption cross section, it is used as a cladding material in all Pressurized Heavy Water Reactors (PHWR). Zirconium oxide is the starting material for the production of zircaloy. It is used in low amounts in the fabrication of plate type of fuels such as Al-U alloy to gain

the desired hardness for the fuel. In view of this, purity requirements of ZrO_2 are similar to those of nuclear fuel materials, specially from neutronics point of view. Besides nuclear industry, zirconium oxide is used as a catalyst as well as a catalyst support. Having good chemical stability and excellent electric conduction, ZrO_2 -based ceramics have been widely applied in manufacturing piezoelectricity components, capacitors, solid electrolyte fuel battery, etc. Because the impurities in high purity ZrO_2 powder strongly influence its properties it is of great importance to determine these trace elements. Trace elemental assay of ZrO_2 thus, assumes great significance from the viewpoint of quality assurance.

Atomic Emission Spectrometry (AES), which is a simultaneously multi-elemental analytical technique with the advantages of acceptable precision and sensitivity, is regularly used for the trace metal assay of nuclear fuels and associated materials [Satyanarayana et al (2010), Rajeswari et al (2002), Sengupta et al (2010, 2011), Bangia et al (1988), Porwal et al (1990), Page et al (1977, 1983) and Purohit et al (2000)]. However, analytical technique based on AES suffers from the spectral interferences. In particular, nuclear materials containing uranium, plutonium, thorium, zirconium due to their emission rich spectra necessitates a development of suitable separation procedure for removal of major matrix without any loss of analytes prior to their determination. Presence of emission rich matrix like U, Pu, Zr can lead to erroneous determination of trace constituents due to spectral interference [Sengupta et al (2013, 2014)]. A number of separation procedures have been reported to achieve trace metal assay of nuclear materials either by chemically [Satyanarayana et al (2010), Rajeswari et al (2002), Sengupta et al (2010, 2011), Bangia et al (1988), Argekar et al (2002), Mahan et al (2000), Malhotra et al (1999), Marin et al (1996) and Huff et al (1989)] or physically [Bangia et al (1988), Porwal et al (1990), Page et al (1977, 1983 and Dalvi et al (1978)]. In dc arc carrier distillation technique suitable carrier is used to sweep out the trace metallic constituents into the

arc leaving the matrix into the graphite electrode. Due to the less sample handling the probability of chance contamination is also found to be less.

In the present case an attempt was made to develop a methodology for determination of trace metallic constituents in ZrO_2 matrix by carrier distillation dc arc spectroscopic method where a mixture of $AgCl$ and SrF_2 was used as a carrier to sweep out the trace constituents into the arc and also maintain the arc stability and temperature. The method developed appears to be promising for the determination of 19 impurities with RSD ~15%.

Experimental

Instrumentation

A 0.75M, Jarrel Ash Direct Reading Spectrometer, fitted with 48 analytical channels, forms the basic operating system. The spectrometer is equipped with d.c. arc and ICP as the sources of spectral excitation. A PDP 11/23 computer along with LA-120 DEC writer is used as a process controller for data acquisition and processing. A RSX-11M basic system supports the software used in the analytical procedure.

Electrodes

Lower electrode (anode): Standard carrier distillation type electrode, viz. ASTM designation E-130-66 type S-2 used on type S-1 pedestal. Upper electrode (cathode): Preformed pointed electrode, ASTM designation E-130-66 type C-I.

Preparation of standard and samples

The analytes of interest in the present studies were: Co, Cr, Mg, B, Be, Cd, Sn, Mn, Cu, Ni, V, Ca, Pb, Fe, Ti, Al, Mo, W and Si. A master standard was prepared by mixing known amounts of the oxides for most of these elements with high purity pre-analyzed zirconium oxide. A standard charge of 100 mg thus contained 5% $AgCl - SrF_2$ mixture ($AgCl : SrF_2 = 4 : 1$), graded proportion of the master standard containing trace amounts of the metallic

elements of interest and pure ZrO₂. Three ZrO₂ samples were prepared synthetically with varying concentrations of trace metals covering the analytical range for precision studies.

Procedure

The choice and proportion of the carrier combination were first optimized by studying the volatilization/excitation characteristics of all the metallic elements. The time-gating facility associated with the direct reading emission spectrometer was used in these studies. The analyte line intensity for an intermediate concentration standard was monitored for one second at each of the sixty three positions available for study of the arc during the exposure period. Other experimental parameters

such as arc current, radial and axial position of the arc plasma etc. were then optimized for gaining high analytical signal for all the elements using the standard prepared with optimized carrier combination. The signal integration time for each of the analytes was also optimized from the study of their volatilization/excitation behavior and finally the analytes were grouped into seven sets of pre-burn and signal integration periods as shown in more detail along with other optimized parameters in Table 1. The d.c. arc analytical response being, in general, a nonlinear one, detailed calibration process was adopted here. The calibration curve for each analytical channel was obtained by using the data based on the replicate observations for each of the entire series of standards.

Table 1: Optimization of instrumental and experimental parameters for the analysis

D.C. arc current:	12.5A		
Sample charge:	100 mg of ZrO ₂ containing 5% carrier (AgCl + SrF ₂)		
Arc gap:	4 mm (constant throughout the exposure period)		
Position:	Symmetric with respect to entrance slit		
Slit-height:	3 mm		
Slit-width:	25 μm		
Exposure time:	Elements	Pre-burn	Exposure
		(s)	(s)
	Cr	5	35
	Cu		
	Fe		
	Mg		
	Mo		
	Pb		
	W		
	Al	10	30
	B	3	20
	Sn		
	V		
	Cd		
		8	35
		2	15

	Ca	5	30
	Be	5	25
	Co		
	Mn		
	Si		
	Ti		

Results and discussion

A systematic study was carried out to develop a methodology for the determination of trace metallic constituents in ZrO₂ matrix. As neutrons are the primary particles causing nuclear fission, their economy is of utmost importance. Elements like B, Cd and some rare earth elements like Eu, Sm, Gd, Dy have very large neutron absorption cross section and their presence results in the loss of neutrons and hence need to be monitored and controlled at ultra trace level. Low melting elements cause liquid metal embrittlement altering the fuel structure. Refractory elements like W, Mo etc. cause creep resistance resulting in clad damage. The presence of light elements results the change in density required for the successful operation of the nuclear reactors at desired burn – up. Fe, Ni, Cr are generally monitored to check the process pick up and the condition of the process equipments. The presence of Fe and Ni at high concentration leads to the sintering problem. The overall impurity content deteriorates the chemical and metallurgical properties of the substance. On view of this it is required to have a critical chemical and physical quality control of the nuclear fuels and associated materials.

Since Zr is multi-elemental being rich in emission spectra is expected to interfere during the determination of other analytes at the trace levels. In the present method, a carrier mixture is chosen to sweep out the trace constituents into the arc leaving major matrix into the graphite electrode.

The elements form refractory compound at arcing conditioned cannot be determined at very low concentration. The carrier mixture also makes the arc stable and maintains constant arc temperature. So a careful choice of carrier is required to achieve the required detection limits and determination range with acceptable precession. In the present case, 5% carrier consisting of a mixture of AgCl and SrF₂ (4:1) was used for physical separation of the trace constituents from the zirconium matrix. The sample is placed inside the cup like anode which is on the graphite pedestal while the cathode is pointed to minimize the arc wandering.

Fig. 1 represents the calibration curves of Co, Cr and Mg, It was observed that though the background intensity of Co 228.6 nm line is more than that of 242.4 nm line, the sensitivity of the former line is an order of magnitude better. 425.4 nm emission line of Cr was found to have slightly better analytical performance with respect to sensitivity and detection limit in comparison with 357.8 nm line of Cr. Mg 280.2 nm line was found to have lower background as well as better sensitivity than 282.5 nm analytical channel. The calibration curves for B- 249.7 nm, Be – 234.8 nm and Cd – 228.8 nm lines were shown in Fig. 2. The calibration curves for B, Be and Cd were obtained in the concentration range of 0.1 µg/g – 10 µg/g while that of Sn 242.1 nm line [Fig. 3] was 1 µg/g – 100 µg/g.

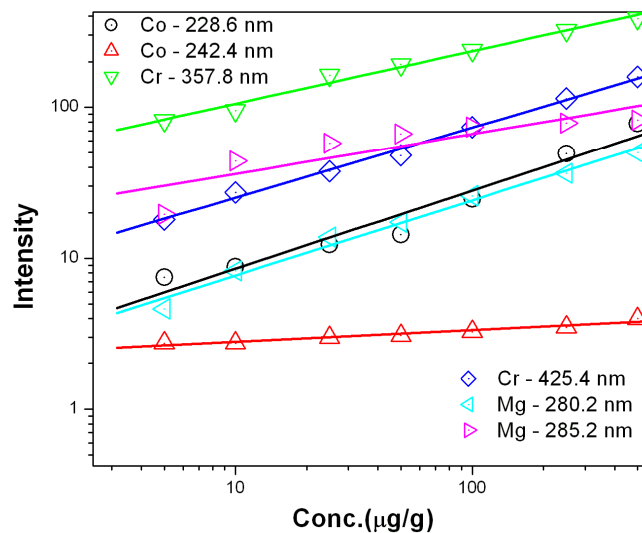


Figure 1: Calibration curves for Co, Cr and Mg

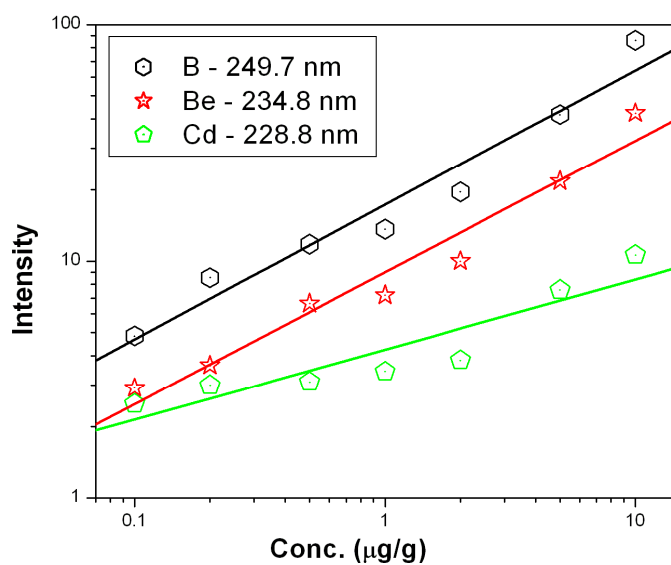


Figure 2: Calibration curves for B, Be and Cd

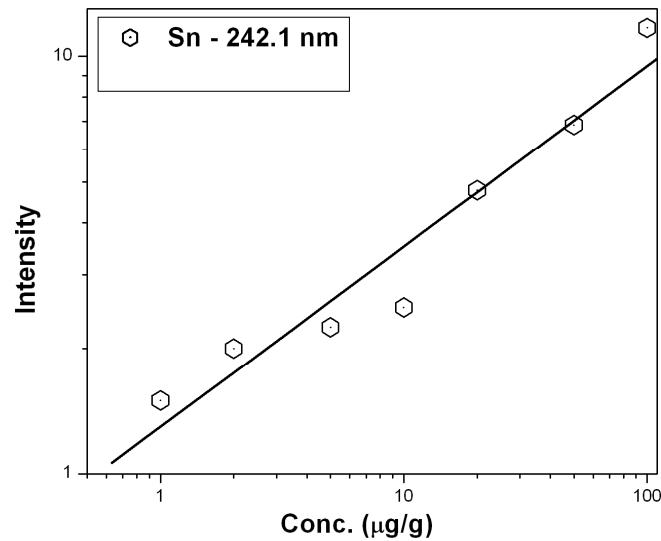


Figure 3: Calibration curve for Sn

Fig. 4 represent the calibration curves for Mn 257.6 nm and Cu 324.7 nm showing a saturation behavior above 100 µg/g for Mn 257.6 nm line. Calibration curves for Ni, V, Ca and Pb represented by Fig. 5 suggested that the calibration curves for the above mentioned elements were established in the concentration range of 5 – 500 µg/g. Ni 305.0 nm line was found to have double sensitivity than the 231.6 nm line inspite of similar detection limits. Both the analytical lines of Ca i.e. 396.8 nm and 422.6 nm were

found to have similar analytical performance. Fe 261.7 nm line was found to have lower detection limit than Fe 259.9 nm line though both of the lines were having similar sensitivity whereas Mo 313.2 nm line is of better analytical performance than 202.0 nm line [Fig. 6]. Fig. 7 represents the calibration curves for W and Si, which suggests that above 2000 µg/g, there is saturation of signal for 288.1 nm Si line due to self-absorption.

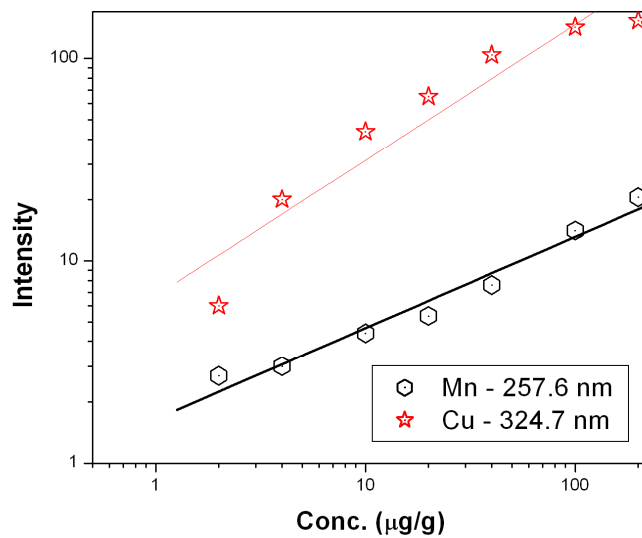


Figure 4: Calibration curves for Mn and Cu

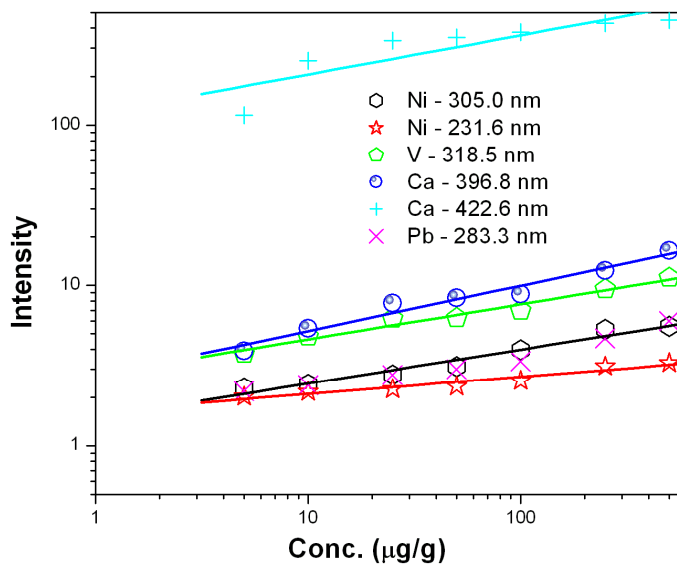


Figure 5: Calibration curves for Ni, V, Ca and Pb

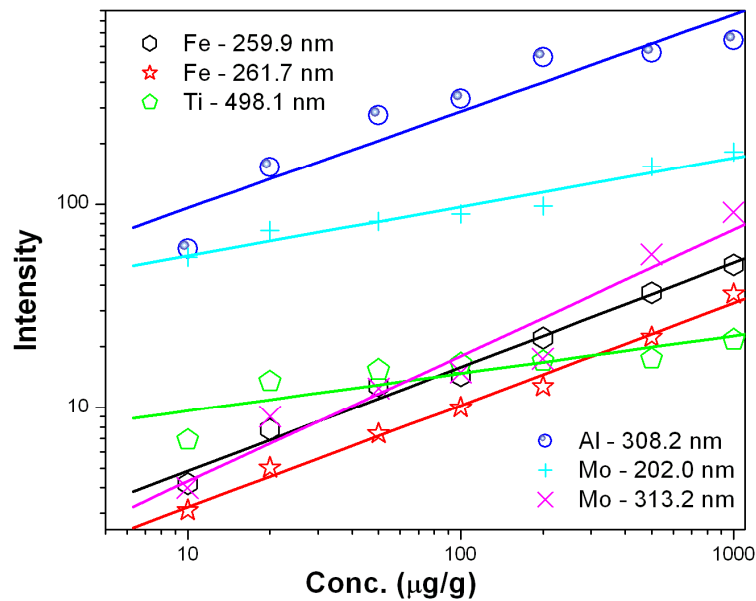


Figure 6: Calibration curves for Fe, Ti, Al and Mo

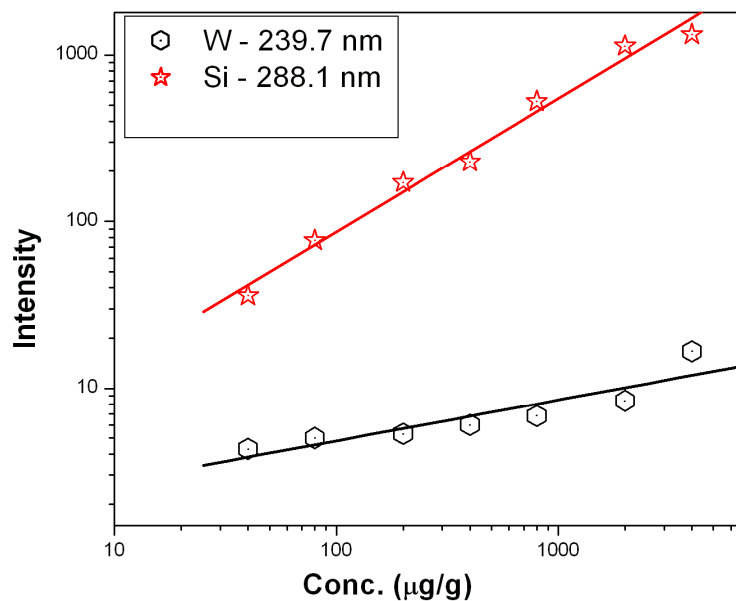


Figure 7: Calibration curves for W and Si

The method was validated using two synthetic samples and it was found to be suitable for the determination of Co, Cr, Mg, B, Be, Cd, Sn, Mn, Cu, Ni, V, Ca, Pb, Fe, Ti, Al,

Mo, W and Si in Zr matrix without any chemical separation with an RSD of ~15%. Table -2 represents the analytical results of the synthetic samples.

Table 2: Determination of trace metallic analytes in Synthetic samples

Element	Synthetic sample-1		Synthetic sample-2	
	Actual conc.	Estimated conc.	Actual conc.	Estimated conc.
	$\mu\text{g/g}$	$\mu\text{g/g}$	$\mu\text{g/g}$	$\mu\text{g/g}$
Al	50	47 ± 6	100	94 ± 9
Be	0.5	0.43 ± 0.04	1	0.8 ± 0.1
B	0.5	0.51 ± 0.03	1	1.2 ± 0.1
Cd	0.5	0.49 ± 0.05	1	1.1 ± 0.1
Ca	25	27 ± 3	50	48 ± 5
Cu	10	9.3 ± 0.6	20	23 ± 2
Co	25	23 ± 3	50	51 ± 5
Cr	25	26 ± 3	50	53 ± 6
Mg	25	22 ± 1	50	49 ± 3
Mn	10	10.3 ± 0.6	20	18 ± 2
Ni	25	22 ± 3	50	55 ± 7
Pb	25	26 ± 2	50	44 ± 6
Fe	50	52 ± 5	100	93 ± 13
Mo	50	46 ± 4	100	103 ± 11
W	200	194 ± 20	400	389 ± 40
Si	200	211 ± 23	400	417 ± 38
Sn	5	4.7 ± 0.5	10	9.4 ± 1
V	25	29 ± 3	50	49 ± 5
Ti	50	51 ± 8	100	96 ± 13

The sensitivity and the detection limits of all the above mentioned analytes were calculated and summarized in Table - 3. The sensitivity was calculated on the basis of the slope of the calibration curves while the detection limit is the concentration

corresponding to the intensity of $\langle x \rangle + 3\sigma$, where $\langle x \rangle$ is the average of the blank intensity value and σ is the standard deviation of the blank measurements. The detection limits were found to be in the range of $0.15 \mu\text{g/g}$ to $36 \mu\text{g/g}$.

Table 3: Determination of the sensitivity and the detection limits of the analytes

Element	Wave length (nm)	Sensitivity (counts/ μg)	Detection limit ($\mu\text{g/g}$)
Co	228.6	0.51	3.5
	242.4	0.07	3.6
Cr	357.8	0.34	2.5
	425.4	0.46	1.6
Mg	280.2	0.49	3.4
	285.2	0.26	3.8

B	249.7	0.57	0.16
Be	234.8	0.56	0.15
Cd	228.8	0.3	0.15
Sn	242.1	0.43	1.7
Mn	257.6	0.45	2.4
Cu	324.7	0.67	0.58
Ni	305	0.21	3.9
	231.6	0.11	4.9
V	318.5	0.22	1.9
Ca	396.8	0.28	4.8
	422.6	0.24	5.5
Pb	283.3	0.21	3.5
Fe	259.9	0.51	16.6
	261.7	0.5	18.4
Ti	498.1	0.18	14.6
Mo	202	0.48	20
	313.2	0.24	9.8
Al	308.2	0.62	4.4
W	239.7	0.25	35.8
Si	288.1	0.8	18

A comparative study was carried out to validate the present methodology with the routinely employed ICP-AES based method using reference ZrO₂ material, certified by Round-Robin experiments (inter laboratory comparison experiment) carried out in different laboratories of Department of Atomic Energy, India. The routinely adopted method for trace metal assay in a Zr matrix is chemical separation of Zr (quantitatively) from the analytes

using 30% TBP-dodecane (five contacts) from an aqueous solution of ~4 M HNO₃, followed by feeding of the aqueous phase into the plasma for analysis [Sengupta et al (2013)]. The above-mentioned routine procedure was adopted and the data were compared with the newly developed methods. The analytical results were summarized in Table 4. The results were found to be satisfactory.

Table 4: Validation of the present method using ZrO₂ reference material and its comparison with routinely employed method

Element	ZrO ₂ Reference Material		
	Actual conc.	Estimated by present method	Estimated by ICP-AES method
	µg/g	µg/g	µg/g
Al	60	62 ± 4	58 ± 2
Be	0.7	0.69 ± 0.05	0.68 ± 0.03
B	1	1.02 ± 0.08	1.1 ± 0.04

Cd	2	2.05 ± 0.09	1.9 ± 0.03
Ca	30	27 ± 3	32 ± 1
Cu	18	18.5 ± 0.9	18.6 ± 0.4
Co	35	36 ± 3	34 ± 1
Cr	30	28 ± 3	29 ± 2
Mg	35	32 ± 3	35 ± 1
Mn	15	15.2 ± 0.9	14.8 ± 0.4
Ni	35	33 ± 3	34 ± 2
Pb	40	37 ± 3	41 ± 2
Fe	70	73 ± 6	68 ± 3
Mo	100	98 ± 7	100 ± 2
W	250	260 ± 20	246 ± 9
Si	150	141 ± 15	145 ± 5
Sn	15	13 ± 2	17 ± 1
V	35	37 ± 4	33 ± 3
Ti	70	71 ± 6	67 ± 3

Conclusion

Zirconium being one of the key elements of nuclear fuel and associated materials, a careful control of its chemical purity is required for the desired performance in the reactors. The present study deals with the development of an analytical method based on dc arc carrier distillation atomic emission spectrometry for simultaneous determination of 18 trace metallic impurities in zirconium matrix. A mixture of AgCl and SrF₂ was used as a carrier for the physical separation of trace constituents from the matrix into the arc to minimize the spectral interference of zirconium on other analytes even at trace level. The experimental parameters were optimized and it was found that the method is promising for the determination of Co, Cr, Mg, B, Be, Cd, Sn, Mn, Cu, Ni, V, Ca, Pb, Fe, Ti, Al, Mo, W and Si in Zr matrix at the trace level with an overall precession of 15%. The methodology was validated using certified reference material using routinely employed methodology.

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